

**Search Notes**

Application/Control No.

10/046,940

Examiner

Ba Huynh

Applicant(s)/Patent under  
Reexamination

BARKER ET AL.

Art Unit

2179

**SEARCHED**

| Class | Subclass | Date       | Examiner |
|-------|----------|------------|----------|
| 715   | 760-767  | 10/17/2006 | HB       |
|       | 776,777  |            |          |
| 717   | 100, 103 |            |          |
|       | 105, 120 |            |          |
|       | 140, 145 |            |          |
|       | 148, 168 |            |          |
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**INTERFERENCE SEARCHED**

| Class                           | Subclass | Date       | Examiner |
|---------------------------------|----------|------------|----------|
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|                                 |          |            |          |
| All classes/subclasses<br>above |          | 10/17/2007 | HB       |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE       | EXMR |
|--|------------|------|
| East: USpat, USpgpub, Epo, Jpo,<br>Derwent, IBM:tdb files search updated | 10/17/2006 | HB   |
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